

<b>Notice of References Cited</b>	Application/Control No. 10/760,155		Applicant(s)/Patent Under Reexamination HETTRICK ET AL.	
	Examiner Shevon E. Johnson		Art Unit 3766	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,156,148	10-1992	Cohen, Todd J.	607/4
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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